Serial EEPROM Series Standard EEPROM WLCSP EEPROM BRCB008GWZ-3

## **General Description**

ROHM

BRCB008GWZ-3 is a serial EEPROM of I<sup>2</sup>C BUS Interface Method

#### Features

- Completely conforming to the world standard I<sup>2</sup>C BUS. All controls available by 2 ports of serial clock (SCL) and serial data (SDA)
- 1.7V to 3.6V Single Power Source Operation most suitable for battery use
- 1.7V to 3.6V wide limit of operating voltage, possible FAST MODE 400KHz operation
- 16byte Page Write Mode useful for initial value write at factory shipment
- Self-timed Programming Cycle
- Low Current Consumption
- Prevention of Write Mistake at Low Voltage
- More than 1 million write cycles
- More than 40 years data retention
- Noise Filter Built in SCL / SDA terminal
- Initial delivery state FFh

#### BRCB008GUZ-3

Capacity	Bit Format	Туре	Power Source Voltage	Package	
8Kbit	1K×8	BRCB008GWZ-3	1.7V to 3.6V	UCSP30L1	

## Package W (Typ) x D(Typ) x H(Max)

UCSP30L1 0.94mm x 0.94mm x 0.33mm

OProduct structure : Silicon monolithic integrated circuit OThis product has no designed protection against radioactive rays

## Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Rating	Unit	Remark
Supply Voltage	Vcc	-0.3 to +6.5	V	
Power Dissipation	Pd	220 (UCSP30L1)	mW	Derate by 2.2mW/°C when operating above Ta=25°C
Storage Temperature	Tstg	-65 to +125	°C	
Operating Temperature	Topr	-40 to +85	°C	
Input Voltage/ Output Voltage	-	-0.3 to Vcc+1.0	V	The Max value of Input Voltage / Output Voltage is not over 6.5V. When the pulse width is 50ns or less, the Min value of Input Voltage / Output Voltage is not lower than 1.0V.
Junction Temperature	Tjmax	150	°C	Junction temperature at the storage condition

## Memory Cell Characteristics (Ta=25°C, Vcc=1.7V to 3.6V)

Parameter		Unit		
Farameter	Min	Тур	Max	Unit
Write Cycles <sup>(1)</sup>	1,000,000	-	-	Times
Data Retention (1)	40	-	-	Years
(1)Not 100% TESTED				

(1)Not 100% TESTED

## **Recommended Operating Ratings**

Parameter	Symbol	Rating	Unit
Power Source Voltage	Vcc	1.7 to 3.6	V
Input Voltage	V <sub>IN</sub>	0 to Vcc	v

## **DC Characteristics** (Unless otherwise specified, Ta=-40°C to +85°C, Vcc=1.7V to 3.6V)

Parameter	Symbol		Limit		Unit	Conditions
Farameter	Symbol	Min	Тур	Max	Unit	Conditions
Input High Voltage	V <sub>IH</sub>	0.7Vcc	-	Vcc+1.0	V	1.7V≦Vcc≦3.6V
Input Low Voltage	VIL	-0.3 <sup>(2)</sup>	-	+0.3Vcc	V	1.7V≦Vcc≦3.6V
Output Low Voltage1	V <sub>OL1</sub>	-	-	0.4	V	I <sub>OL</sub> =3.0mA, 2.5V≦Vcc≦3.6V (SDA)
Output Low Voltage2	V <sub>OL2</sub>	-	-	0.2	V	I <sub>OL</sub> =0.7mA, 1.7V≦Vcc<2.5V (SDA)
Input Leakage Current	ILI	-1	-	+1	μA	V <sub>IN</sub> =0 to Vcc
Output Leakage Current	ILO	-1	-	+1	μA	V <sub>OUT</sub> =0 to Vcc (SDA)
Supply Current (Write)	I <sub>CC1</sub>	-	-	2.0	mA	Vcc=3.6V, f <sub>SCL</sub> =400kHz, t <sub>WR</sub> =5ms, Byte Write, Page Write
Supply Current (Read)	I <sub>CC2</sub>	-	-	0.5	mA	Vcc=3.6V, f <sub>SCL</sub> =400kHz Random Read, Current Read, Sequential Read
Standby Current	I <sub>SB</sub>	-	-	2.0	μA	Vcc=3.6V, SDA · SCL=Vcc

(2) When the pulse width is 50ns or less, it is -1.0V.

## AC Characteristics (Unless otherwise specified, Ta=-40°C to +85°C, Vcc=1.7V to 3.6V)

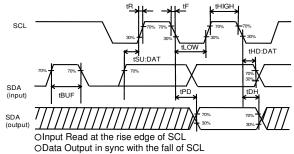
Deremeter	Symbol		Linit			
Parameter	Symbol	Min	Min Typ		- Unit	
Clock Frequency	f <sub>SCL</sub>	-	-	400	kHz	
Data Clock High Period	t <sub>HIGH</sub>	0.6	-	-	μs	
Data Clock Low Period	t <sub>LOW</sub>	1.2	-	-	μs	
SDA and SCL Rise Time <sup>(1)</sup>	t <sub>R</sub>	-	-	0.3	μs	
SDA and SCL Fall Time <sup>(1)</sup>	t <sub>F</sub>	-	-	0.3	μs	
Start Condition Hold Time	t <sub>HD:STA</sub>	0.6	-	-	μs	
Start Condition Setup Time	t <sub>SU:STA</sub>	0.6	-	-	μs	
Input Data Hold Time	t <sub>HD:DAT</sub>	0	-	-	ns	
Input Data Setup Time	t <sub>SU:DAT</sub>	100	-	-	ns	
Output Data Delay Time	t <sub>PD</sub>	0.1	-	0.9	μs	
Output Data Hold Time	t <sub>DH</sub>	0.1	-	-	μs	
Stop Condition Setup Time	t <sub>SU:STO</sub>	0.6	-	-	μs	
Bus Free Time	t <sub>BUF</sub>	1.2	-	-	μs	
Write Cycle Time	t <sub>wR</sub>	-	-	5	ms	
Noise Spike Width (SDA and SCL)	tı	-	-	0.1	μs	

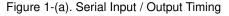
(1) Not 100% TESTED.

Condition Input Data Level: VIL=0.2×Vcc VIH=0.8×Vcc

Input Data Timing Reference Level: 0.3×Vcc/0.7×Vcc Output Data Timing Reference Level: 0.3×Vcc/0.7×Vcc Rise/Fall Time: ≦20ns

## Serial Input / Output Timing





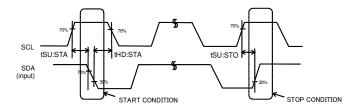


Figure 1-(b). Start-Stop Bit Timing

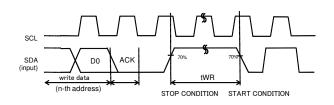


Figure 1-(c). Write Cycle Timing

## **Block Diagram**

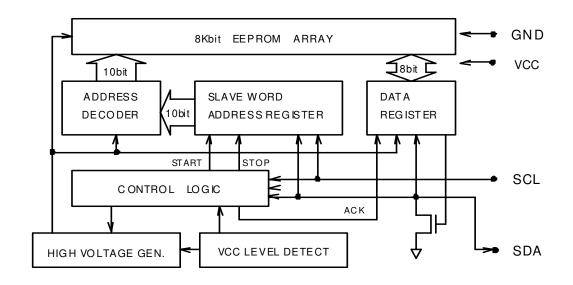
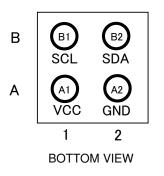


Figure 2. Block Diagram

## **Pin Configuration**



## **Pin Descriptions**

Land No.	Terminal Name	Input / Output	Descriptions
B2	SDA	Input / Output	Slave and word address Serial data input and serial data output
B1	SCL	Input	Serial clock input
A2	GND	-	Reference voltage of all input / output
A1	VCC	-	Power supply

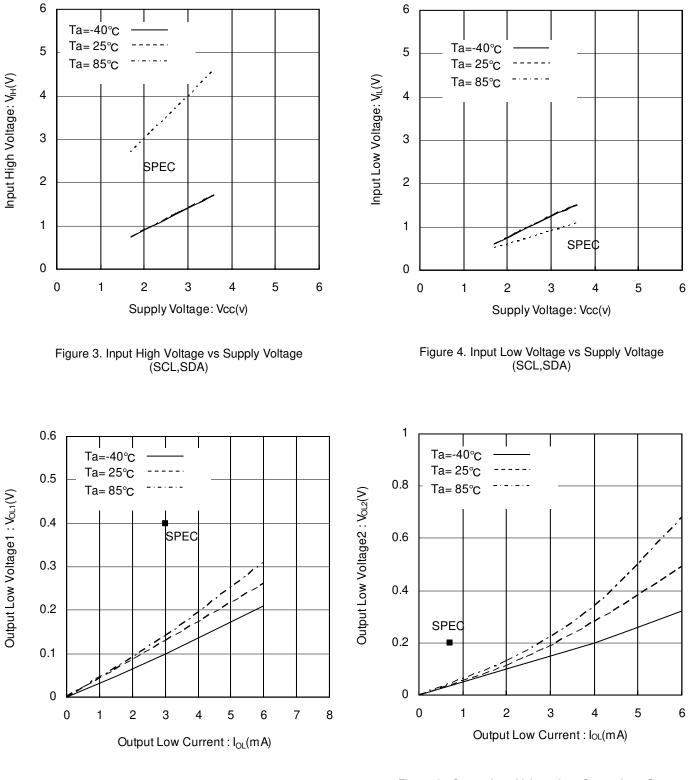
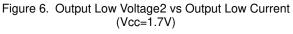


Figure 5. Output Low Voltage1 vs Output Low Current (Vcc=2.5V)



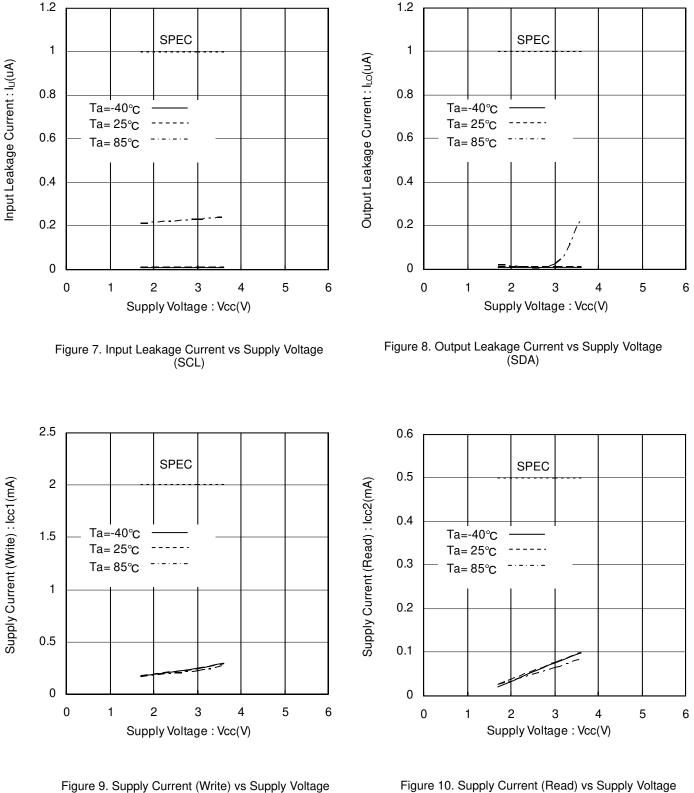
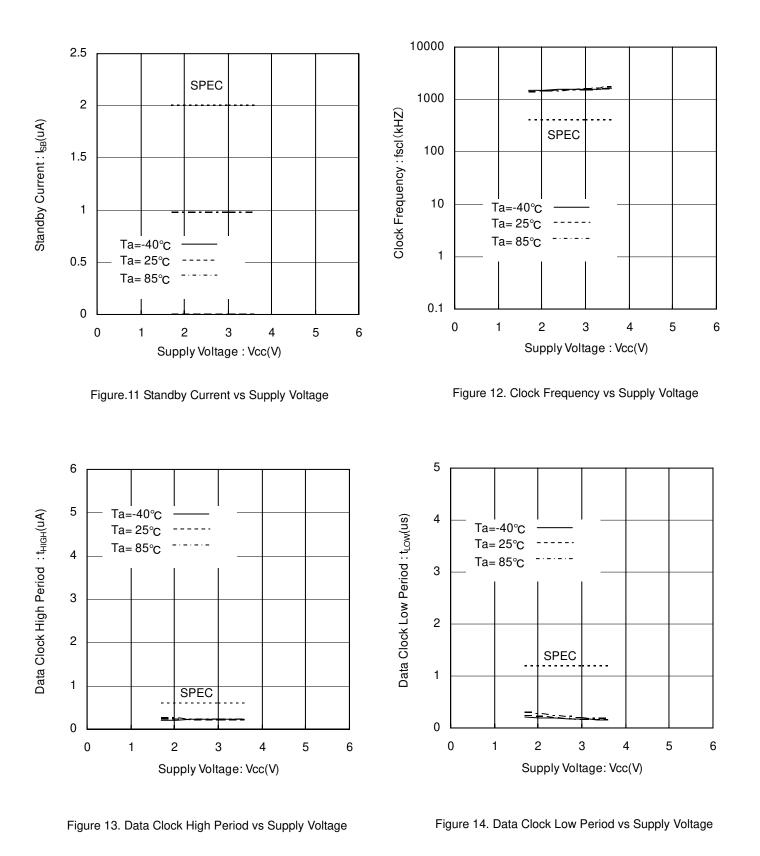


Figure 10. Supply Current (Read) vs Supply Voltage (f<sub>SCL</sub>=400kHz)

 $(f_{SCL}=400 kHz)$ 



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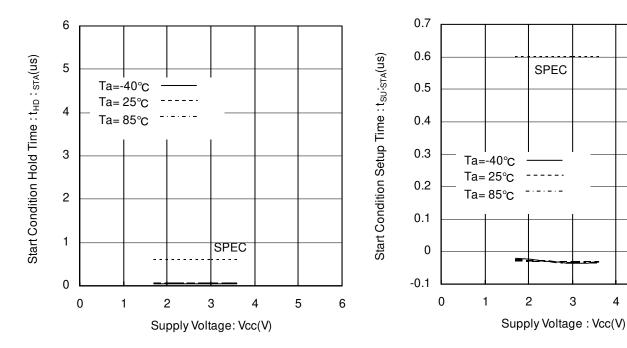


Figure 15. Start Condition Hold Time vs Supply Voltage

Figure 16. Start Condition Setup Time vs Supply Voltage

3

4

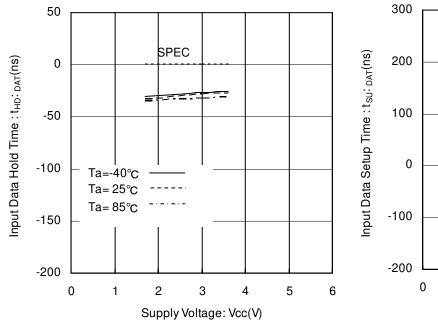
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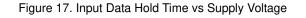
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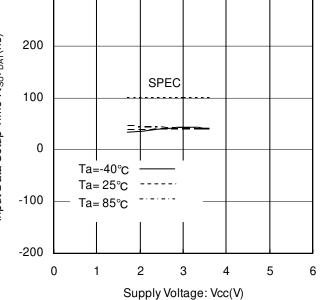


Figure 18. Input Data Setup Time vs Supply Voltage

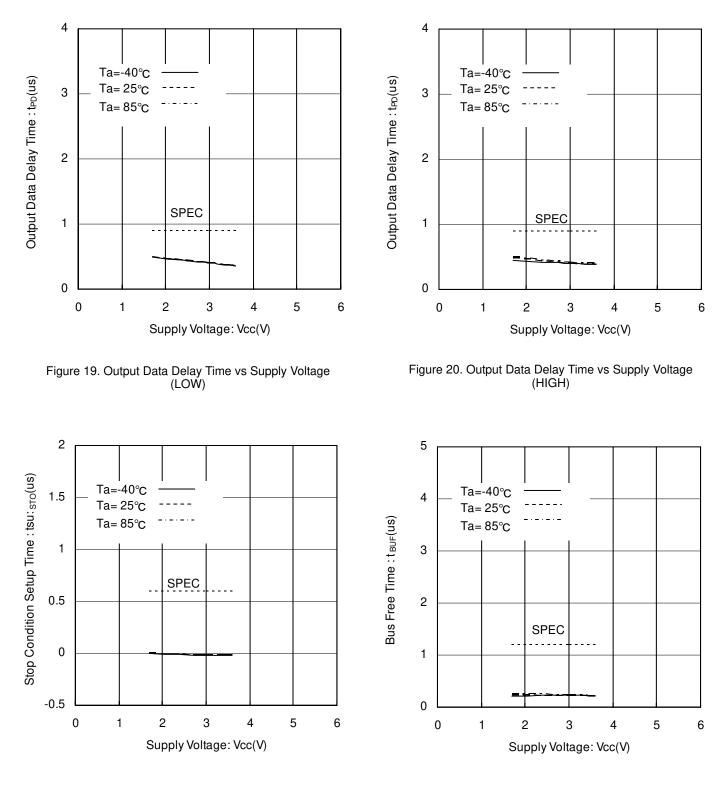


Figure 21. Stop Condition Setup Time vs Supply Voltage

Figure 22. Bus Free Time vs Supply Voltage

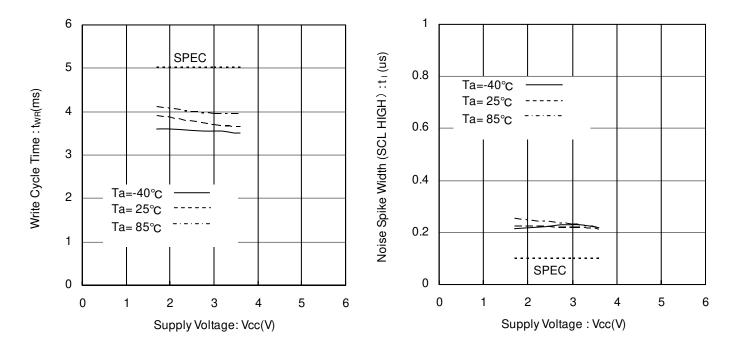
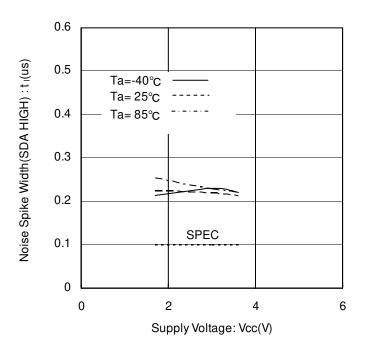


Figure 23. Write Cycle Time vs Supply Voltage



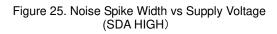


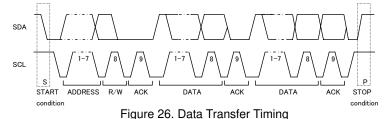
Figure 24. Noise Spike Width vs Supply Voltage (SCL HIGH)

## **Timing Chart**

## 1. I<sup>2</sup>C BUS Data Communication

I<sup>2</sup>C BUS data communication starts by start condition input, and ends by stop condition input. Data is always 8bit long, and acknowledge is always required after each byte. I<sup>2</sup>C BUS data communication with several devices is possible by connecting with 2 communication lines; serial data (SDA) and serial clock (SCL).

Among the devices, there should be a "master" that generates clock and control communication start and end. The rest become "slave" which is controlled by an address peculiar to each device like this EEPROM. The device that outputs data to the bus during data communication is called "transmitter", and the device that receives data is called "receiver".



## 2. Start Condition (Start Bit Recognition)

- Before executing each command, start condition (start bit) where SDA goes from 'HIGH' down to 'LOW' when SCL is 'HIGH' is necessary.
- (2) This IC always detects whether SDA and SCL are in start condition (start bit) or not, therefore, unless this condition is satisfied, any command cannot be executed.

## 3. Stop Condition (Stop Bit Recognition)

(1) Each command can be ended by a stop condition (stop bit) where SDA goes from 'LOW' to 'HIGH' while SCL is 'HIGH'.

## 4. Acknowledge (ACK) Signal

- (1) This acknowledge (ACK) signal is a software rule to show whether data transfer has been made normally or not. In a master and slave communication, the device (Ex. μ-COM sends slave address input for write or read command to this IC) at the transmitter (sending) side releases the bus after output of 8bit data.
- (2) The device (Ex. This IC receives the slave address input for write or read command from the μ-COM) at the receiver (receiving) side sets SDA 'LOW' during the 9th clock cycle, and outputs acknowledge signal (ACK signal) showing that it has received the 8bit data.
- (3) This IC, after recognizing start condition and slave address (8bit), outputs acknowledge signal (ACK signal) 'LOW'.
- (4) After receiving 8bit data (word address and write data) during each write operation, this IC outputs acknowledge signal (ACK signal) 'LOW'.
- (5) During read operation, this IC outputs 8bit data (read data), and detects acknowledge signal (ACK signal) 'LOW'. When acknowledge signal (ACK signal) is detected, and stop condition is not sent from the master (μ-COM) side, this IC continues to output data. When acknowledge signal (ACK signal) is not detected, this IC stops data transfer, recognizes stop condition (stop bit), and ends read operation. Then this IC becomes ready for another transmission.

## 5. Device Addressing

- (1) Slave address comes after start condition from master.
- (2) The significant 4 bits of slave address are used for recognizing a device type.
- The device code of this IC is fixed to '1010'.
- (3) Next slave addresses (P1, P0 --- page select) are for selecting page addresses.
- (4) The most insignificant bit (R/W --- READ / WRITE) of slave address is used for designating write or read operation, and is as shown below.

Setting  $R/\overline{W}$  to 0 ------ write (setting 0 to word address setting of random read) Setting  $R/\overline{W}$  to 1 ------ read

Туре	Slave Address							
BRCB008GWZ-3		0	1	0	*	P1	P0	R/Ŵ

\* don't care

## Write Command

- 1. Write Cycle
  - (1) Arbitrary data can be written to this EEPROM. When writing only 1 byte, Byte Write is normally used, and when writing continuous data of 2 bytes or more, simultaneous write is possible by Page Write Cycle. Up to 16 arbitrary bytes can be written.

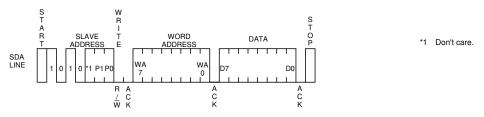


Figure 27. Byte Write Cycle

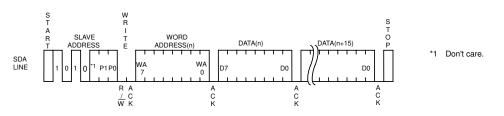


Figure 28. Page Write Cycle

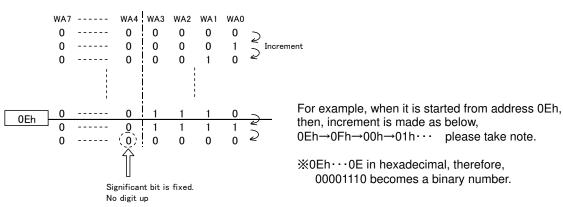
- (2) During internal write execution, all input commands are ignored, therefore ACK is not returned.
- (3) Data is written to the address designated by word address (n-th address)
- (4) By issuing stop bit after 8bit data input, internal write to memory cell starts.
- (5) When internal write is started, command is not accepted for  $t_{WR}$  (5ms at maximum).
- (6) Using page write cycle, writing in bulk is done as follows: When data of more than 16 bytes is sent, the byte in excess overwrites the data already sent first.
  (Refer to "Internal address increment".)
- (7) As for Page Write Command, where 2 or more bytes of data is intended to be written, after page select bit 'P0,P1' of slave address are designated arbitrarily, only the value of 4 least significant bits in the address is incremented internally, so that data up to 32 addresses of memory only can be written.

#### 2. Notes on Page Write Cycle

1 page=16bytes, but the page Write Cycle Time is 5ms at maximum for 16byte bulk write. It does not stand 5ms at maximum × 16byte=80ms(Max)

#### 3. Internal Address Increment

Page Write Mode



## **Read Command**

#### 1. Read Cycle

Read cycle is when data of EEPROM is read. Read cycle could be random read cycle or current read cycle. Random read cycle is a command to read data by designating a specific address, and is used generally. Current read cycle is a command to read data of internal address register without designating an address, and is used when to verify just after write cycle. In both the read cycles, sequential read cycle is available where and the next address data can be read in succession.

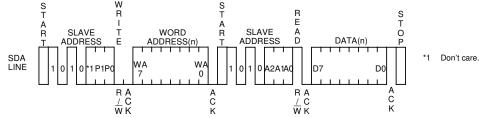


Figure 29. Random Read Cycle

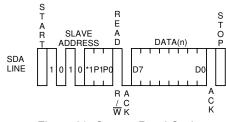


Figure 30. Current Read Cycle

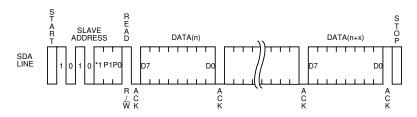


Figure 31. Sequential Read Cycle (in the case of Current Read Cycle)

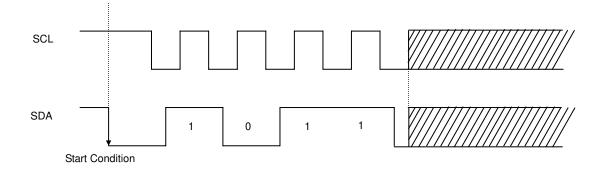
- (1) In Random Read Cycle, data of designated word address can be read.
- (2) When the command just before Current Read Cycle is Random Read Cycle, Current Read Cycle (each including Sequential Read Cycle), data of incremented last read address (n)-th, i.e., data of the (n+1)-th address is output.
- (3) When ACK signal 'LOW' after D0 is detected, and stop condition is not sent from master (μ-COM) side, the next address data can be read in succession.
- (4) Read cycle is ended by stop condition where 'H' is input to ACK signal after D0 and SDA signal goes from 'L' to 'H' while SCL signal is 'H'.
- (5) When 'H' is not input to ACK signal after D0, sequential read gets in, and the next data is output. Therefore, read command cycle cannot be ended. To end the read command cycle, be sure to input 'H' to ACK signal after D0, and the stop condition where SDA goes from 'L' to 'H' while SCL signal is 'H'.
- (6) Sequential Read is ended by stop condition where 'H' is input to ACK signal after arbitrary D0 and SDA is asserted from 'L' to 'H' while SCL signal is 'H'.

## **Prohibition Command**

This command is Test Mode Command. (Figure 32.)

If this device receives this command by error, it becomes Test Mode and may cause erroneous operation in system. To assure the operation, never send the following command.

The release condition of Test Mode is only power down.





## Software Reset

Software reset is executed to avoid malfunction after power on and during command input. Software reset has several kinds and 3 kinds of them are shown in the figure below. (Refer to Figure 33-(a), Figure 33-(b), and Figure 33-(c).) Within the dummy clock input area, the SDA bus is released ('H' by pull up) and ACK output and read data '0' (both 'L' level) may be output from EEPROM. Therefore, if 'H' is input forcibly, output may conflict and over current may flow, leading to instantaneous power failure of system power source or influence upon devices.

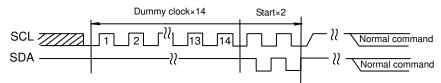
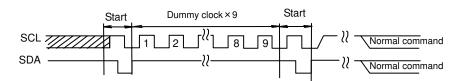
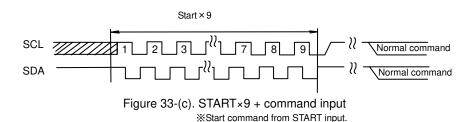


Figure 33-(a). The case of dummy clock×14 + START+START+ command input







## Acknowledge Polling

During internal write execution, all input commands are ignored, therefore ACK is not returned. During internal automatic write execution after write cycle input, next command (slave address) is sent. If the first ACK signal sends back 'L', then it means end of write operation, else 'H' is returned, which means writing is still in progress. By the use of acknowledge polling, next command can be executed without waiting for  $t_{WR} = 5ms$ .

To write continuously,  $R/\overline{W} = 0$ , then to carry out current read cycle after write, slave address with  $R/\overline{W} = 1$  is sent, and if ACK signal sends back 'L', then execute word address input and data output and so forth.

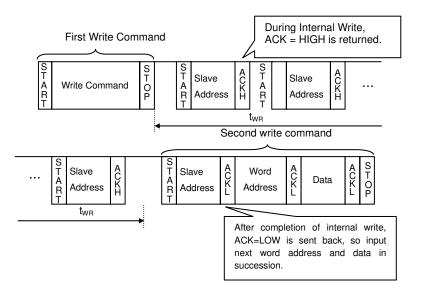


Figure 34. Case of continuous write by Acknowledge Polling

## Command Cancel by Start Condition and Stop Condition

During command input, by continuously inputting start condition and stop condition, command can be cancelled. (Figure 35) However, within ACK output area and during data read, SDA bus may output 'L'. In this case, start condition and stop condition cannot be input, so reset is not available. Therefore, execute software reset. When command is cancelled by start, stop condition, during random read cycle, sequential read cycle, or current read cycle, internal setting address is not determined. Therefore, it is not possible to carry out current read cycle in succession. To carry out read cycle in succession, carry out random read cycle.

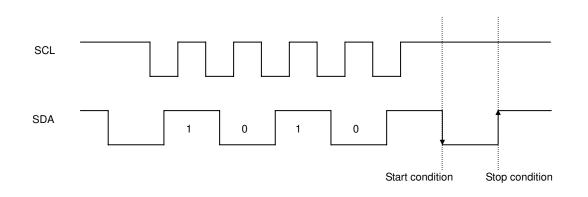


Figure 35. Case of Cancel by Start, Stop Condition during Slave Address Input

## I/O Peripheral Circuit

### 1. Pull-up Resistance of SDA terminal

SDA is NMOS open drain, so it requires a pull up resistor. As for this resistance value ( $R_{PU}$ ), select an appropriate value from microcontroller  $V_{IL}$ ,  $I_L$ , and  $V_{OL}$ - $I_{OL}$  characteristics of this IC. If  $R_{PU}$  is large, operating frequency is limited. The smaller the  $R_{PU}$ , the larger is the supply current (Read).

## 2. Maximum Value of RPU

The maximum value of  $R_{PU}$  is determined by the following factors.

- (1) SDA rise time to be determined by the capacitance ( $\tilde{C}_{BUS}$ ) of bus line and  $R_{PU}$  of SDA should be  $t_R$  or lower.
- Furthermore, AC timing should be satisfied even when SDA rise time is slow.
- (2)The bus electric potential A to be determined by the input current leak total (I<sub>L</sub>) of the device connected to the bus with output of 'H' to the SDA line and R<sub>PU</sub> should sufficiently secure the input 'H' level (V<sub>IH</sub>) of microcontroller and EEPROM including recommended noise margin of 0.2Vcc.

 $\text{Vcc-I}_{\text{L}}\text{R}_{\text{PU}}\text{-}0.2 \text{ Vcc } \geqq \text{ V}_{\text{IH}}$ 

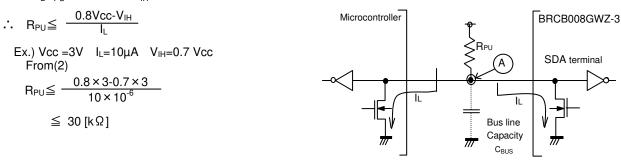


Figure 36. I/O Circuit Diagram

## 3. Minimum Value of $R_{PU}$

The minimum value of  $R_{PU}$  is determined by the following factors:

(1)When IC outputs LOW, it should be satisfied that  $V_{\text{OLMAX}}{=}0.4V$  and  $I_{\text{OLMAX}}{=}3\text{mA}.$ 

 $\frac{V_{CC}-V_{OL}}{R_{PU}} \leq I_{OL}$  $\therefore R_{PU} \geq \frac{V_{CC}-V_{OL}}{I_{OL}}$ 

(2)Volmax=0.4V should secure the input 'L' level (V<sub>IL</sub>) of microcontroller and EEPROM including the recommended noise margin of 0.1Vcc.

 $\begin{array}{l} \mathsf{V}_{\mathsf{OLMAX}} \leqq \mathsf{V}_{\mathsf{IL}}\text{-}0.1 \ \mathsf{V}_{\mathsf{CC}} \\ \mathsf{Ex.} \mathsf{)} \ \mathsf{V}_{\mathsf{CC}} = \mathsf{3V}, \ \mathsf{V}_{\mathsf{OL}} = 0.4 \mathsf{V}, \ \mathsf{I}_{\mathsf{OL}} = \mathsf{3mA}, \ \mathsf{microcontroller}, \ \mathsf{EEPROM} \ \mathsf{V}_{\mathsf{IL}} = 0.3 \mathsf{V}_{\mathsf{CC}} \\ \mathsf{from}(1) \\ \mathsf{R}_{\mathsf{PU}} \geqq \frac{3 \cdot 0.4}{3 \times 10^3} \\ \geqq 867[\Omega] \\ \mathsf{And} \quad \mathsf{V}_{\mathsf{OL}} = 0.4 \ [\mathsf{V}] \\ \mathsf{V}_{\mathsf{IL}} = 0.3 \times 3 \\ = 0.9 \ [\mathsf{V}] \\ \end{aligned}$ Therefore, the condition (2) is satisfied.

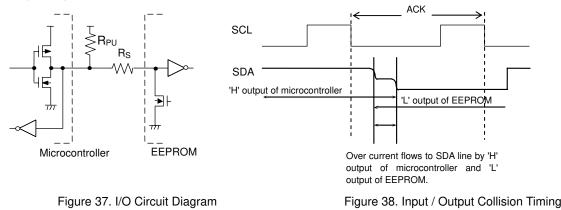
#### 4. Pull-up Resistance of SCL Terminal

When SCL control is made at the CMOS output port, there is no need for a pull up resistor. But when there is a time where SCL becomes 'Hi-Z', add a pull up resistor. As for the pull up resistor value, one of several k $\Omega$  to several ten k $\Omega$  is recommended in consideration of drive performance of output port of microcontroller.

## **Cautions on Microcontroller Connection**

1. Rs

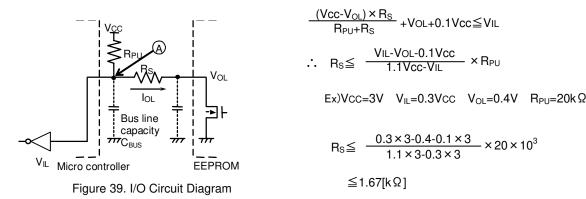
In I<sup>2</sup>C BUS, it is recommended that SDA port is of open drain input/output. However, when using CMOS input / output of tri state to SDA port, insert a series resistance Rs between the pull up resistor Rpu and the SDA terminal of EEPROM. This is to control over current that may occur when PMOS of the microcontroller and NMOS of EEPROM are turned ON simultaneously.  $R_S$  also plays the role of protecting the SDA terminal against surge. Therefore, even when SDA port is open drain input/output,  $R_S$  can be used.



#### 2. Maximum Value of $R_S$

The maximum value of Rs is determined by the following relations.

- (1) SDA rise time to be determined by the capacitance  $(C_{BUS})$  of bus line and  $R_{PU}$  of SDA should be  $t_R$  or lower. Furthermore, AC timing should be satisfied even when SDA rise time is slow.
- (2) The bus electric potential A to be determined by  $R_{PU}$  and  $R_S$  the moment when EEPROM outputs 'L' to SDA bus should sufficiently secure the input 'L' level ( $V_{IL}$ ) of microcontroller including recommended noise margin of 0.1Vcc.



#### 3. Minimum Value of R<sub>s</sub>

The minimum value of  $R_s$  is determined by over current at bus collision. When over current flows, noises in power source line and instantaneous power failure of power source may occur. When allowable over current is defined as I, the following relation must be satisfied. Determine the allowable current in consideration of the impedance of power source line in set and so forth. Set the over current to EEPROM at 10mA or lower.

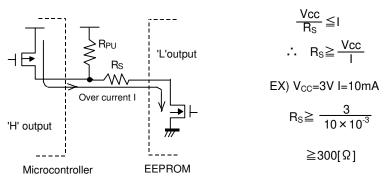


Figure 40. I/O Circuit Diagram

## I/O Equivalence Circuit

1. Input (SCL)

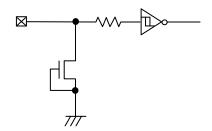


Figure 41. Input Pin Circuit Diagram

2. Input / Output (SDA)

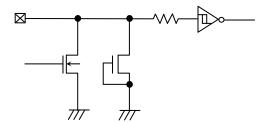


Figure 42. Input / Output Pin Circuit Diagram

V<sub>bot</sub>

0.3V or below

0.2V or below

## Power-Up/Down Conditions

At power on, the IC's internal circuit may go through unstable low voltage area as the Vcc rises, making the IC's internal logic circuit not completely reset, hence, malfunction may occur. To prevent this, the IC is equipped with POR circuit and LVCC circuit. To assure the operation, observe the following conditions at power on.

- 1. Set SDA = 'H' and SCL ='L' or 'H'
- 2. Start power source so as to satisfy the recommended conditions of t<sub>R</sub>, t<sub>OFF</sub>, and V<sub>bot</sub> for operating POR circuit.

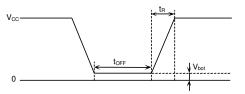


Figure 43. Rise Waveform Diagram

3. Set SDA and SCL so as not to become 'Hi-Z'.

When the above conditions 1 and 2 cannot be observed, take the following countermeasures.

(1) In the case when the above condition 1 cannot be observed such that SDA becomes 'L' at power on.  $\rightarrow$  Control SCL and SDA as shown below, to make SCL and SDA, 'H' and 'H'.

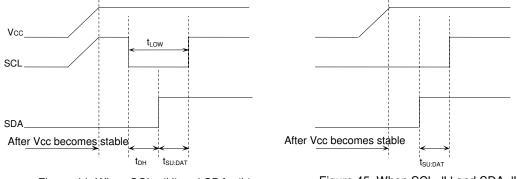
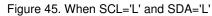


Figure 44. When SCL= 'H' and SDA= 'L'



Recommended conditions of t<sub>R</sub>, t<sub>OFF</sub>, V<sub>bot</sub>

toff

10ms or larger

10ms or larger

t<sub>R</sub>

10ms or below

100ms or below

- (2) In the case when the above condition 2 cannot be observed.
- $\rightarrow$ After power source becomes stable, execute software reset(Page 15).
- (3) In the case when the above conditions 1 and 2 cannot be observed.  $\rightarrow$  Carry out (1), and then carry out (2).

#### Low Voltage Malfunction Prevention Function

LVCC circuit prevents data rewrite operation at low power and prevents write error. At LVCC voltage (Typ =1.2V) or below, data rewrite is prevented.

#### **Noise Countermeasures**

#### 1. Bypass Capacitor

When noise or surge gets in the power source line, malfunction may occur, therefore, it is recommended to connect a bypass capacitor  $(0.1\mu F)$  between the IC's Vcc and GND. Connect the capacitor as close to the IC as possible. In addition, it is also recommended to connect a bypass capacitor between the board's Vcc and GND.

## **Operational Notes**

- 1. Described numeric values and data are design representative values only and the values are not guaranteed.
- 2. We believe that the application circuit examples in this document are recommendable. However, in actual use, confirm characteristics further sufficiently. If changing the fixed number of external parts is desired, make your decision with sufficient margin in consideration of static characteristics, transient characteristics, and fluctuations of external parts and our LSI.
- 3. Absolute maximum ratings

If the absolute maximum ratings such as supply voltage, operating temperature range and so on are exceeded, LSI may be destroyed. Do not supply voltage or subject the IC to temperature exceeding the absolute maximum ratings. In the case of fear of exceeding the absolute maximum ratings, take physical safety countermeasures such as adding fuses, and see to it that conditions exceeding the absolute maximum ratings should not be supplied to the LSI.

4. GND electric potential

Set the voltage of GND terminal lowest at any operating condition. Make sure that each terminal voltage is not lower than that of GND terminal.

- Thermal design Use a thermal design that allows for a sufficient margin by taking into account the permissible power dissipation (Pd) in actual operating conditions.
- Short between pins and mounting errors
   Be careful when mounting the IC on printed circuit boards. The IC may be damaged if it is mounted in a wrong
   orientation or if pins are shorted together. Short circuit may be caused by conductive particles caught between the pins.
- 7. Operating the IC in the presence of strong electromagnetic field may cause malfunction, therefore, evaluate design sufficiently.

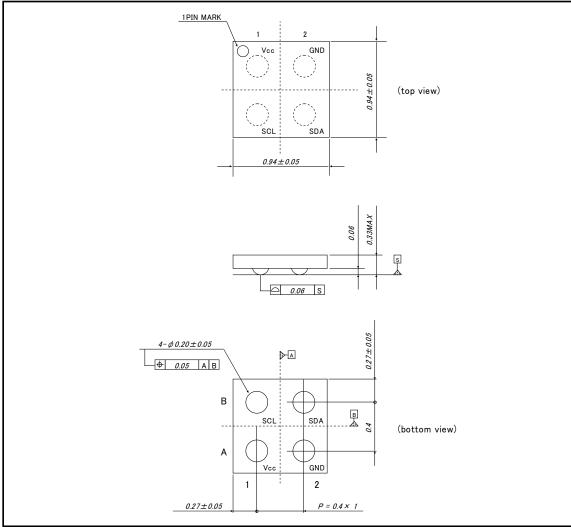
## Part Numbering

	В	R	С	В	0	0	8	G	W	Ζ	-	3	E	2
BU C :	I <b>S type</b> I <sup>2</sup> C													
Re	vision													
<b>Ca</b>	<b>pacity</b> 8=8K													
	<b>ckage</b> VZ : UCS	SP30L <sup>-</sup>	1											
Pr	ocess C	ode												
Pa	ackaging	and f	orming	j speci	ficatio	on								

E2 : : Embossed tape and reel

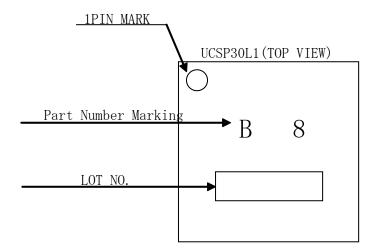
## Physical Dimensions Tape and Reel Information





<tape and="" information="" reel=""></tape>								
Таре	Embossed carrier tape							
Quantity	6000pcs							
Direction of feed	. The direction is the 1nin of product is at the upper left when you hold a							
	Reel *Order quantity needs to be multiple of the minimum quantity.							

## Marking Diagram



## **Revision History**

Date	Revision	Changes
18.Aug.2012	001	New Release
25.Feb.2013	002	Update some English words, sentences' descriptions, grammar and formatting. Update Part Numbering.

# Notice

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1. Our Products are designed and manufactured for application in ordinary electronic equipments (such as AV equipment, OA equipment, telecommunication equipment, home electronic appliances, amusement equipment, etc.). If you intend to use our Products in devices requiring extremely high reliability (such as medical equipment <sup>(Note 1)</sup>, transport equipment, traffic equipment, aircraft/spacecraft, nuclear power controllers, fuel controllers, car equipment including car accessories, safety devices, etc.) and whose malfunction or failure may cause loss of human life, bodily injury or serious damage to property ("Specific Applications"), please consult with the ROHM sales representative in advance. Unless otherwise agreed in writing by ROHM in advance, ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of any ROHM's Products for Specific Applications.

JAPAN	USA	EU	CHINA
CLASSⅢ	CLASSⅢ	CLASS II b	CLASSI
CLASSⅣ		CLASSⅢ	

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  - [b] Installation of redundant circuits to reduce the impact of single or multiple circuit failure
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  - [b] Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
  - [C] Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [d] Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
  - [e] Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
  - [f] Sealing or coating our Products with resin or other coating materials
  - [g] Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
  - [h] Use of the Products in places subject to dew condensation
- 4. The Products are not subject to radiation-proof design.
- 5. Please verify and confirm characteristics of the final or mounted products in using the Products.
- 6. In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- 7. De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- 8. Confirm that operation temperature is within the specified range described in the product specification.
- 9. ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

#### Precaution for Mounting / Circuit board design

- 1. When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- 2. In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

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#### **Precaution for Electrostatic**

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of lonizer, friction prevention and temperature / humidity control).

#### **Precaution for Storage / Transportation**

- 1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
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  - [b] the temperature or humidity exceeds those recommended by ROHM
  - [c] the Products are exposed to direct sunshine or condensation
  - [d] the Products are exposed to high Electrostatic
- 2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
- 3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
- 4. Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

#### **Precaution for Product Label**

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#### Precaution for Disposition

When disposing Products please dispose them properly using an authorized industry waste company.

#### Precaution for Foreign Exchange and Foreign Trade act

Since our Products might fall under controlled goods prescribed by the applicable foreign exchange and foreign trade act, please consult with ROHM representative in case of export.

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